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Application/Control No.	Applicant(s)/Patent under Reexamination
10/817,365	LUCAS, BRIAN R.
Examiner	Art Unit
David T. Fidei	3728

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Class	Subclass	Date	Examiner
206	232 315.1 315.9 579		
40	312		
283	56 57 70	8/9/2005	DTF
Updated	Above	11/28/2005	DTF

INT	INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH)
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